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Authors: Xu Lu, Lei Hou, Li Jin, Dawei Wang, Qingyuan Hu, D.O. Alikin, A. Pu. Turygin, Liang Wang, Lin Zhang, Xiaoyong Wei



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Origin of composition-insensitive electrostrictive coefficient and continuous decrease of domain wall density in $(1-x)\text{NaNbO}_3\text{-}x\text{BaTiO}_3$ lead-free ferroelectrics

Xu Lu^{a,*}, Lei Hou^a, Li Jin^{b,*}, Dawei Wang^{c,*}, Qingyuan Hu^d, D. O. Alikin^d, A. Pu. Turygin^d,
Liang Wang^a, Lin Zhang^b, Xiaoyong Wei^b

^a *Laboratory of Functional Films, School of Materials Science and Engineering, Xi'an University of Technology, Xi'an 710048, China*

^b *Electronic Materials Research Laboratory, School of the Electronic and Information Engineering, Xi'an Jiaotong University, Xi'an 710049, China*

^c *School of Microelectronics & State Key Laboratory for Mechanical Behavior of Materials, Xi'an Jiaotong University, Xi'an 710049, China*

^d *School of Natural Sciences and Mathematics, Ural Federal University, Ekaterinburg 620000, Russia*

*Corresponding authors.

E-mail addresses: luxury.1@gmail.com (X. Lu), ljin@mail.xjtu.edu.cn (L. Jin),

dawei.wang@mail.xjtu.edu.cn (D. Wang)

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